

TOSHIBA IGBT Module Silicon N Channel IGBT

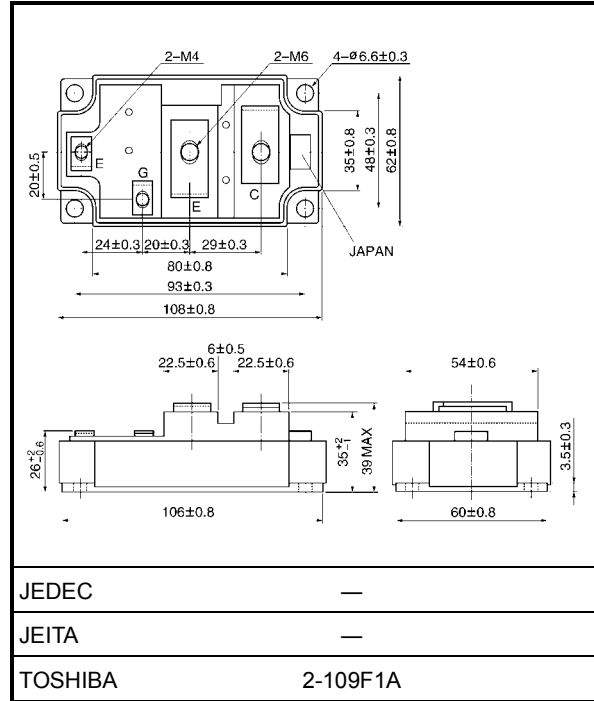
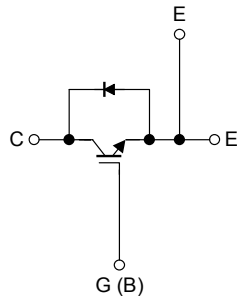
MG400Q1US65H

High Power & High Speed Switching Applications

Unit: mm

- High input impedance
- Enhancement-mode
- The electrodes are isolated from case.

Equivalent Circuit



Weight: 465 g (typ.)

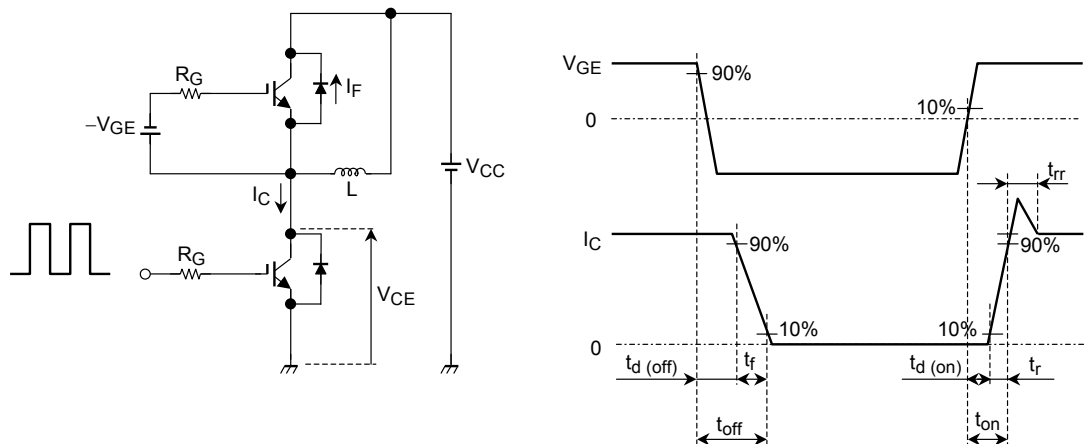
Maximum Ratings (Ta = 25°C)

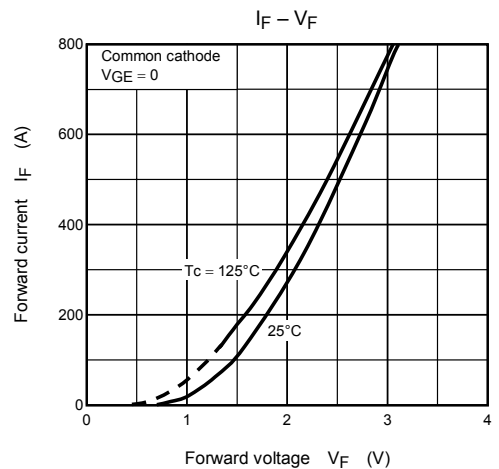
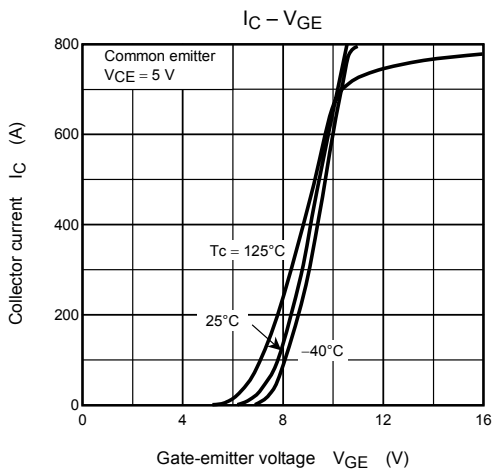
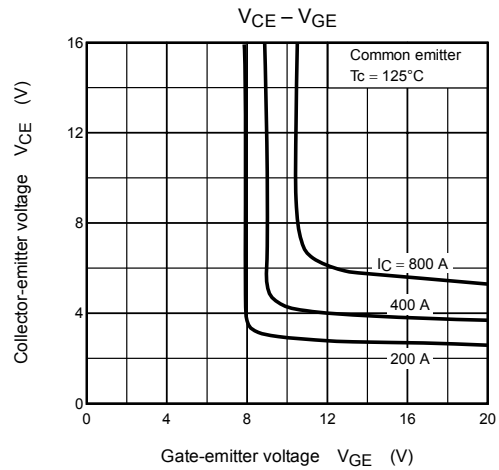
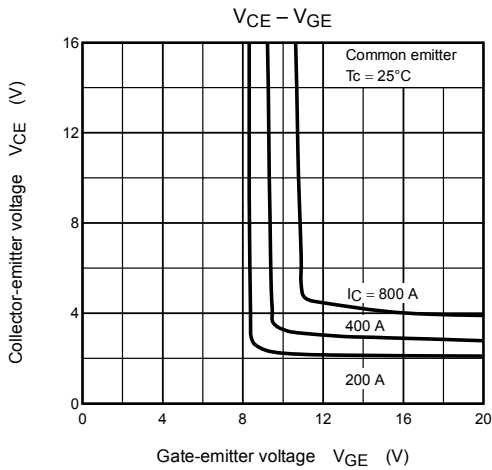
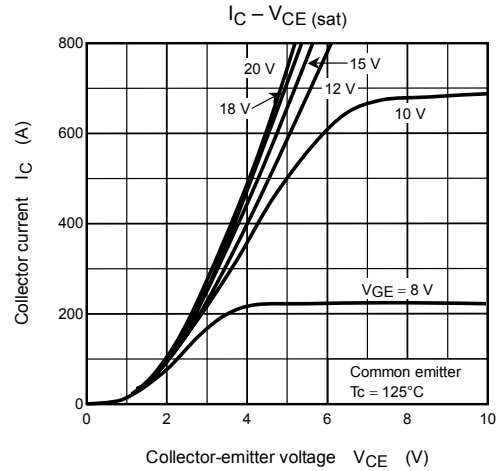
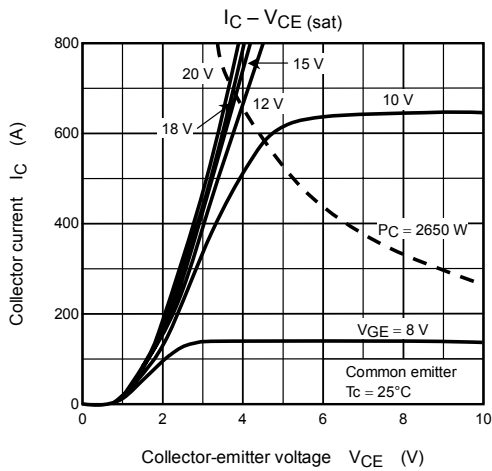
Characteristics	Symbol	Rating	Unit
Collector-emitter voltage	V_{CES}	1200	V
Gate-emitter voltage	V_{GES}	±20	V
Collector current	DC	I_C	A
	1 ms	I_{CP}	
Forward current	DC	I_F	A
	1 ms	I_{FM}	
Collector power dissipation (Tc = 25°C)	P_C	2650	W
Junction temperature	T_j	150	°C
Storage temperature range	T_{stg}	-40 to 125	°C
Isolation voltage	V_{isol}	2500 (AC 1 minute)	V
Screw torque	Terminal	—	N·m
	Mounting	—	

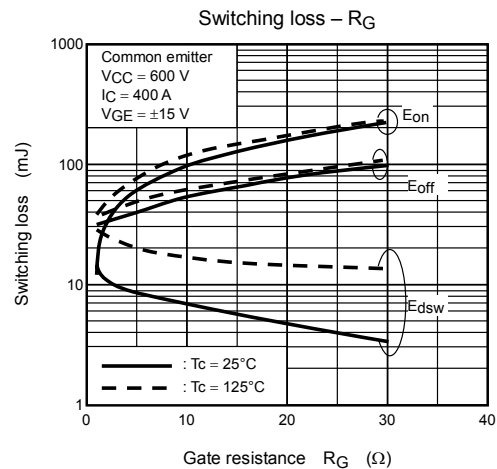
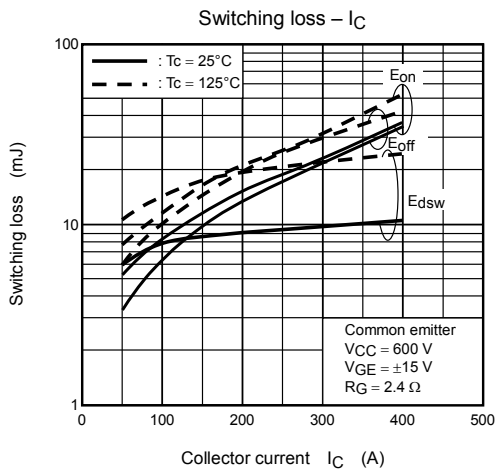
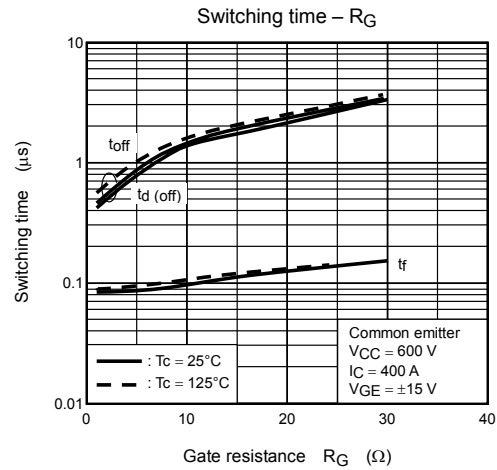
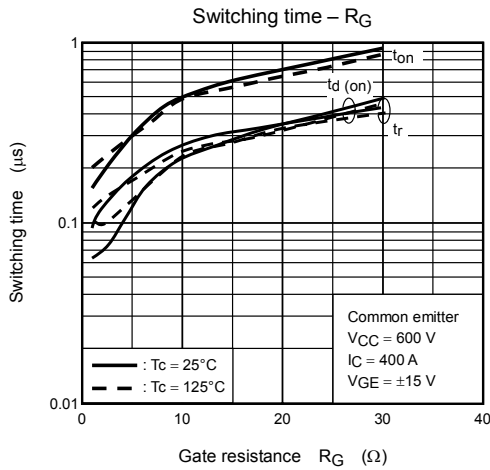
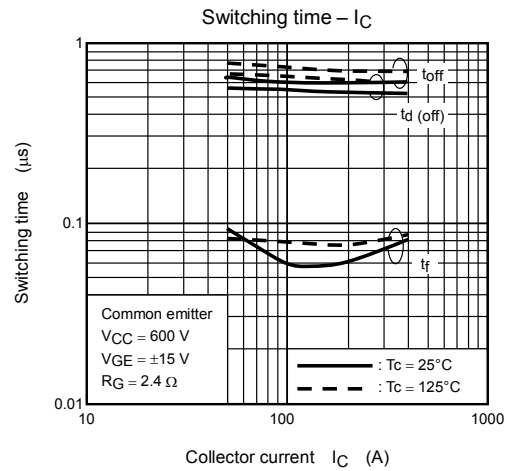
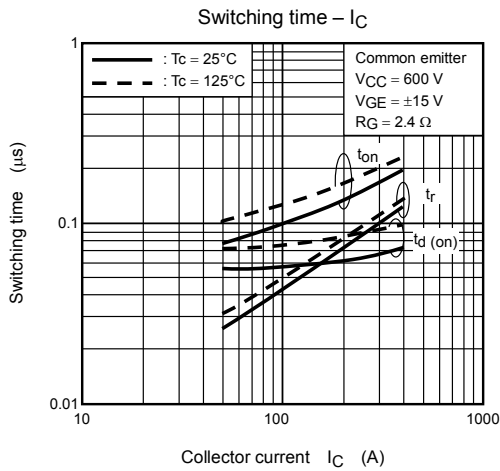
Electrical Characteristics (Ta = 25°C)

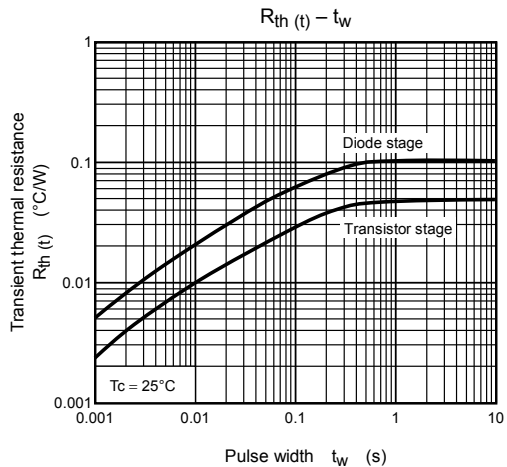
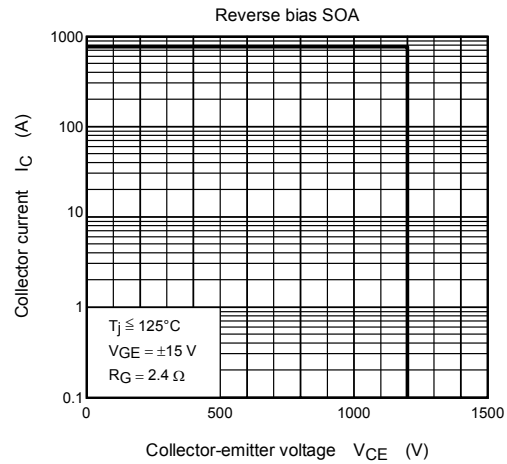
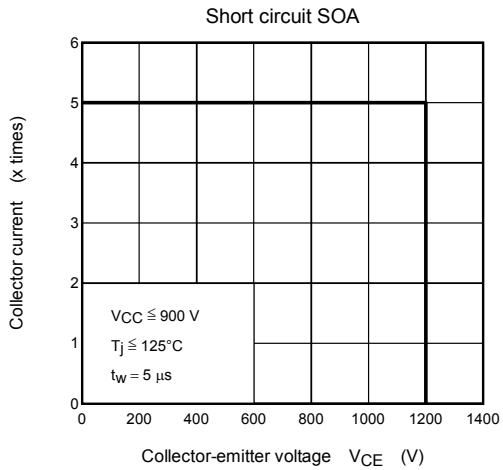
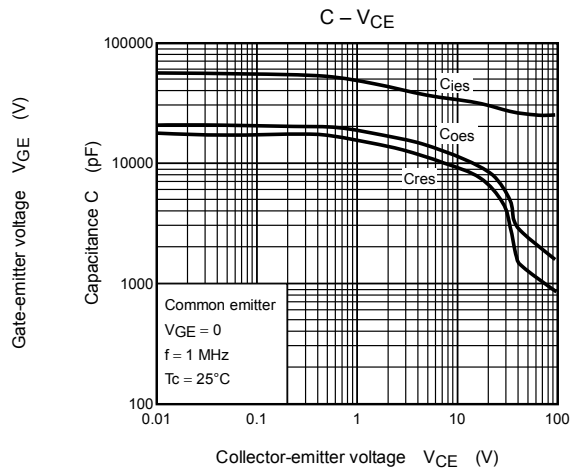
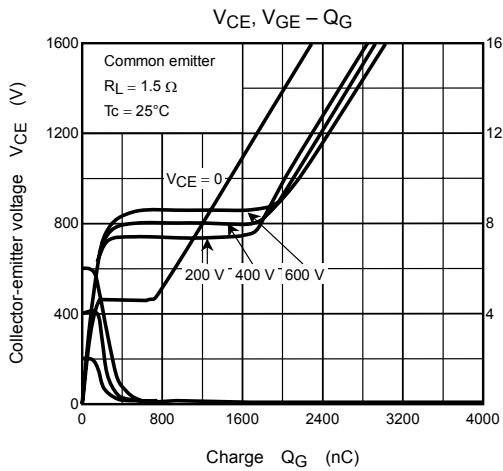
Characteristics		Symbol	Test Condition	Min	Typ.	Max	Unit	
Gate leakage current		I_{GES}	$V_{GE} = \pm 20 \text{ V}, V_{CE} = 0$	—	—	± 500	nA	
Collector cut-off current		I_{CES}	$V_{CE} = 1200 \text{ V}, V_{GE} = 0$	—	—	4.0	mA	
Gate-emitter cut-off voltage		$V_{GE} \text{ (off)}$	$I_C = 400 \text{ mA}, V_{CE} = 5 \text{ V}$	4.0	—	7.0	V	
Collector-emitter saturation voltage		$V_{CE} \text{ (sat)}$	$I_C = 400 \text{ A}, V_{GE} = 15 \text{ V}$	$T_c = 25^\circ\text{C}$	—	3.0	4.0	V
				$T_c = 125^\circ\text{C}$	—	3.6	—	
Input capacitance		C_{ies}	$V_{CE} = 10 \text{ V}, V_{GE} = 0, f = 1 \text{ MHz}$	—	34000	—	pF	
Switching time	Turn-on delay time	$t_d \text{ (on)}$	Inductive load $V_{CC} = 600 \text{ V}, I_C = 400 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_G = 2.4 \Omega$	—	0.05	—	μs	
	Rise time	t_r		—	0.05	—		
	Turn-on time	t_{on}		—	0.10	—		
	Turn-off delay time	$t_d \text{ (off)}$		—	0.55	—		
	Fall time	t_f		—	0.05	0.15		
	Turn-off time	t_{off}		—	0.60	—		
Forward voltage		V_F	$I_F = 400 \text{ A}, V_{GE} = 0$	—	2.4	3.5	V	
Reverse recovery time		t_{rr}	$I_F = 400 \text{ A}, V_{GE} = -10 \text{ V}$	—	0.25	—	μs	
Thermal resistance		$R_{th} \text{ (j-c)}$	Transistor stage	—	—	0.047	$^\circ\text{C/W}$	
			Diode stage	—	—	0.1		
Switching loss	Turn-on	E_{on}	Inductive load $V_{CC} = 600 \text{ V}, I_C = 400 \text{ A}$ $V_{GE} = \pm 15 \text{ V}, R_G = 2.4 \Omega$ $T_c = 125^\circ\text{C}$	—	40	—	mJ	
	Turn-off	E_{off}		—	40	—		

Note: Switching time measurement circuit and input/output waveforms









RESTRICTIONS ON PRODUCT USE

030619EAA

- The information contained herein is subject to change without notice.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any patent or patent rights of TOSHIBA or others.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- TOSHIBA products should not be embedded to the downstream products which are prohibited to be produced and sold, under any law and regulations.